Search Notes

Appl	ication/	Con	trol	No.

Applicant(s)/Patent under Reexamination

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Art Unit

Jungwon Chang

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SEARCHED				
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709	223	5/16/2005	JWC	
707	104.1	5/16/2005	ıwc	

INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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East text NPL: Google ACM IEEE	5/16/2005	JWC	